

# **Nickel-Palladium-Gold: A Cost Effective, Sn-Whisker- Free Termination Finish**

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# Acknowledgement

The work presented here is abstracted from a paper written by myself and Se Chuel Park ([sech.park@samsung.com](mailto:sech.park@samsung.com)) of Samsung Techwin Co., Ltd as members of the HDP Users Group.

The complete paper is located at:

[www.hdpug.org/public/4-papers/2005/2005.htm](http://www.hdpug.org/public/4-papers/2005/2005.htm)

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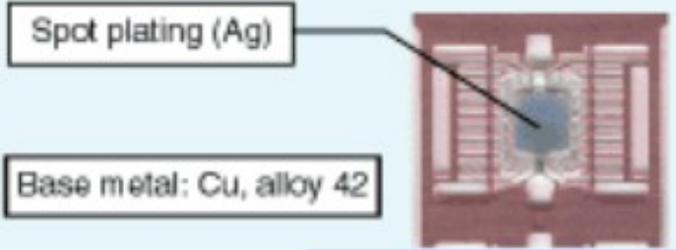
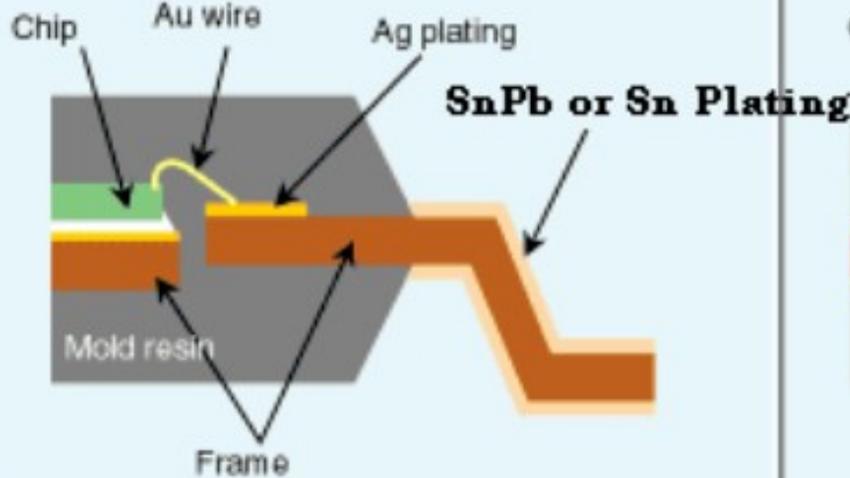
Texas Instruments

# Objectives

- **NiPdAu Pre-Plated Finishes** (PPF's) are economical and effective Pb-free finishes for IC leads.
- No risk of **Sn whiskers** with NiPdAu PPF.
- Tens of **billions** IC's are in use with NiPd and NiPdAu PPF finished leads; sold over the past 15 years.
- **Cost** of the NiPdAu based leadframe finishes has been addressed by reducing the Pd content by ~7X and adding an ultra thin (30~100 angstrom) top layer of Au.
- **Solderability** performance is equivalent to that of fusible Sn finishes.

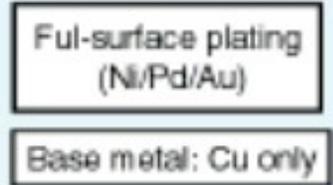
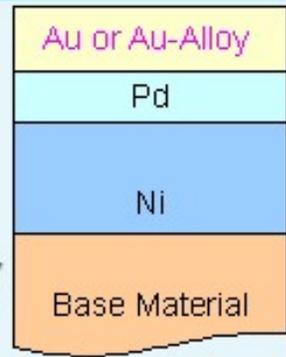
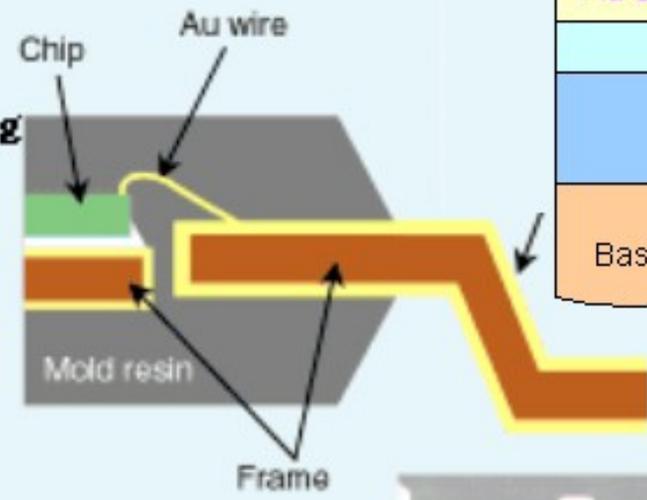
# Plating Comparison

## SnPb or Sn Plating



External view of lead frame

## NiPd Based PPF



External view of lead frame

# Some History

- In 1989, Texas Instruments introduced NiPd finished leads, converting >90% of their leaded product to **NiPd** within 2 years.
- The functional finish at that time was **2-layers**:
  - **0.075 $\mu$  (3u") Pd** over
  - **2 $\mu$  (80u") Ni**
  - Pd was ~\$120/toz., but ranged up to \$1000/toz.
  - Pd is currently at \$180-\$185/toz.

# Sn Whiskers

- Mechanism for Sn whiskers is not still understood – 50+ years of recognition.
- For Sn on Cu; related to stress in Sn layer.
- But, mechanism for Sn movement (stress relief) not well defined.
  
- Sn whiskers represent an unbounded \$ risk to IC manufacturers using matte Sn.

# Sn Whiskers

**The #1 mitigation technique for whiskering : simply “don’t use tin finish”.**

# Sn Whiskers

*“Any claims for “whisker-free” tin-plating processes, or guaranteed lifetimes without a whisker failure, must be regarded with skepticism at this time.”*

Joe Smetana, Alcatel  
ECTC, 2004

# JEDEC Std 201

## **“ENVIRONMENTAL ACCEPTANCE REQUIREMENTS FOR TIN WHISKER SUSCEPTIBILITY OF TIN AND TIN ALLOY SURFACE FINISHES”**

- Final Ballot Draft for JESD201 out on 9-1-05

# JEDEC Whisker Growth Test Method

JEDEC standard JESD22A121, "Test Method for Measuring Whisker Growth on Tin and Tin Alloy Surface Finishes"

Published May 2005, details a suite of tests that provide:

- an industry-standard method of measuring and comparing whisker propensity for different plating or finish chemistries and processes
- a consistent inspection protocol for tin whisker examination
- a standard reporting format

# Some Misconceptions About NiPdAu PPF

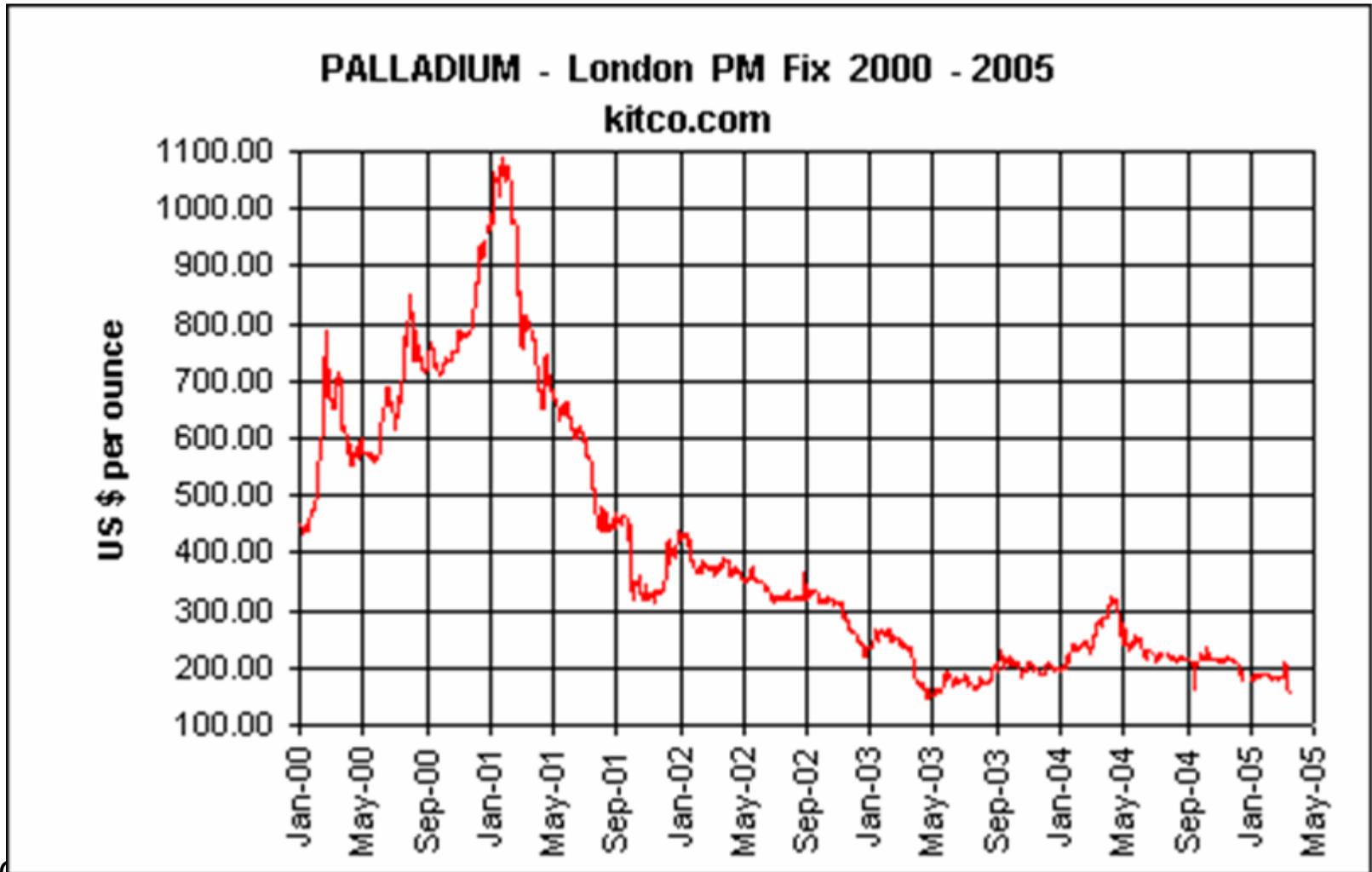
- High **cost** of this plated finish
- Issues in the IC assembly process
  - Plating **cracking** after lead forming
- **Soldering** and fillet shape after board mount

# Cost: Lowering Pd Content

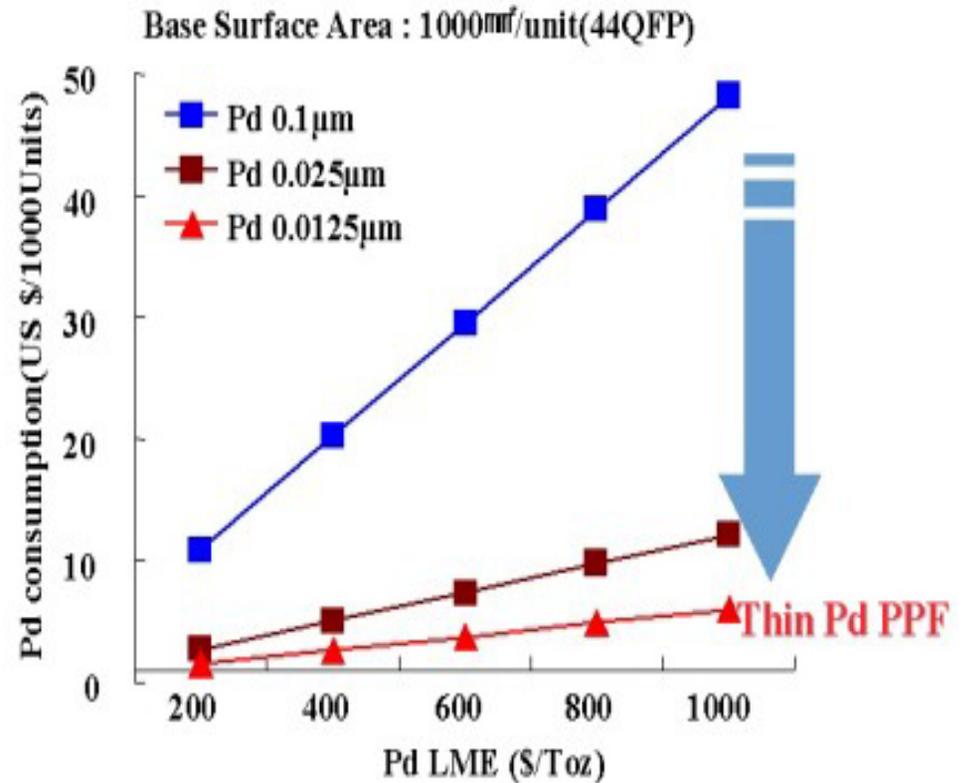
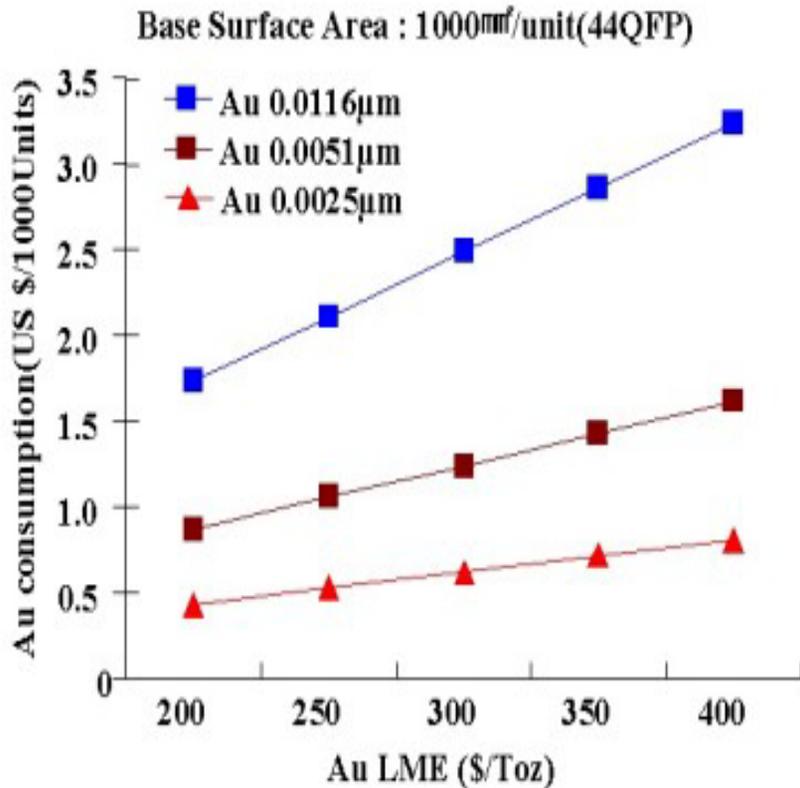
Now NiPdAu PPF are 3-layer structures.

- **Ni** over the base metal, 0.5 - 2  $\mu$
  - **Pd** 0.01 - 0.15  $\mu$  (2-layer 0.075 – 0.15 $\mu$ )
  - **Au** or Au-alloy, 0.003 – 0.015 $\mu$
- 
- **Pd** content has been reduced by ~ 7X,  
added 30 - 150 angstrom of **Au**

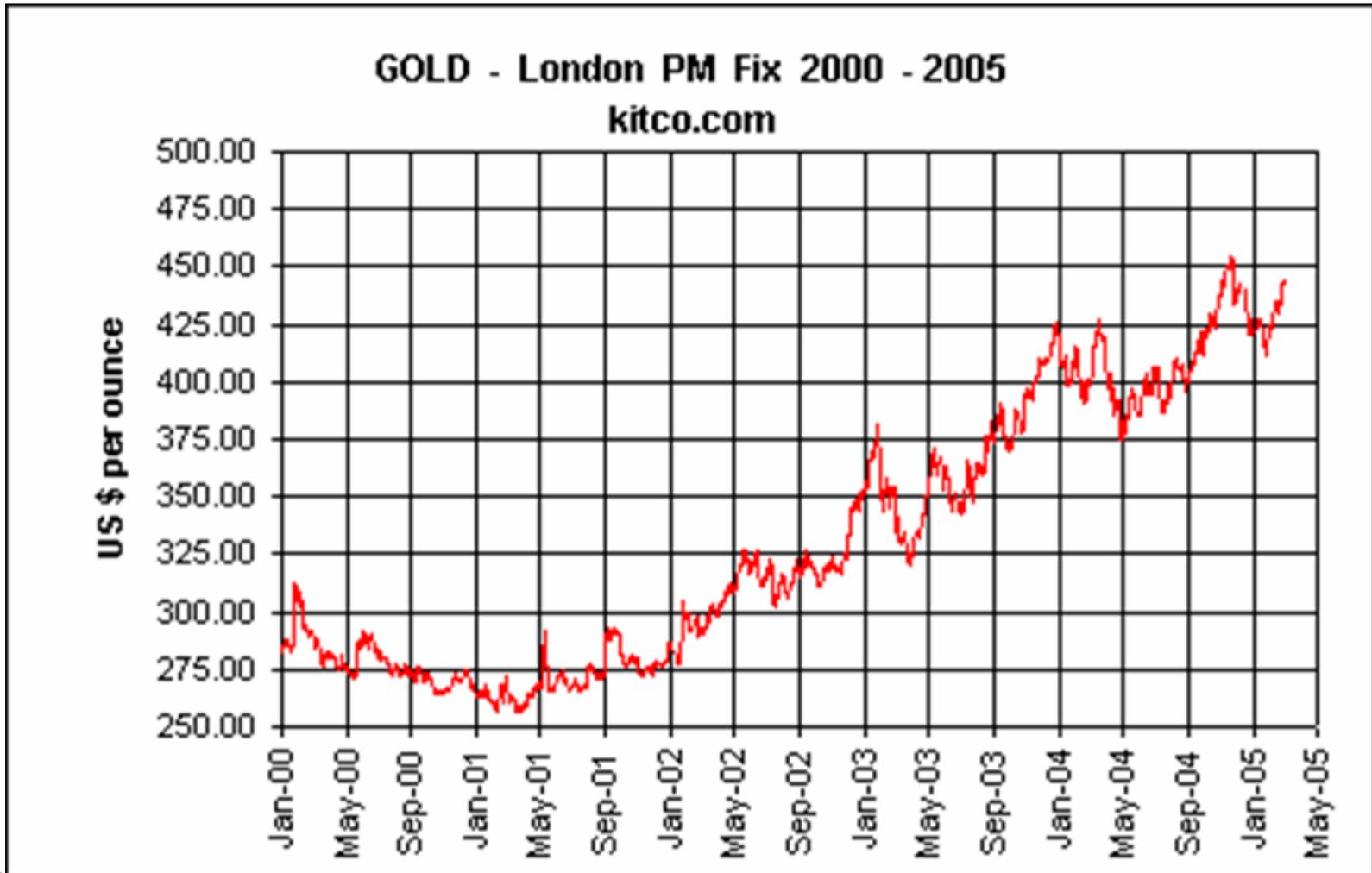
# Pd Price History



# PM Price v. Thickness, Sensitivity



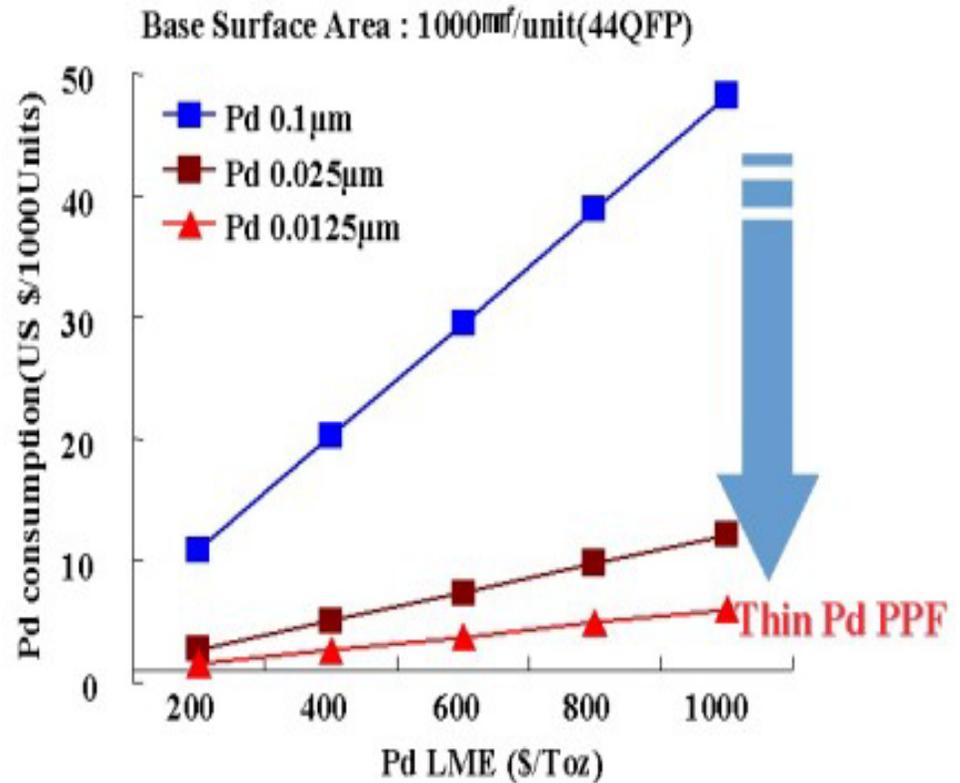
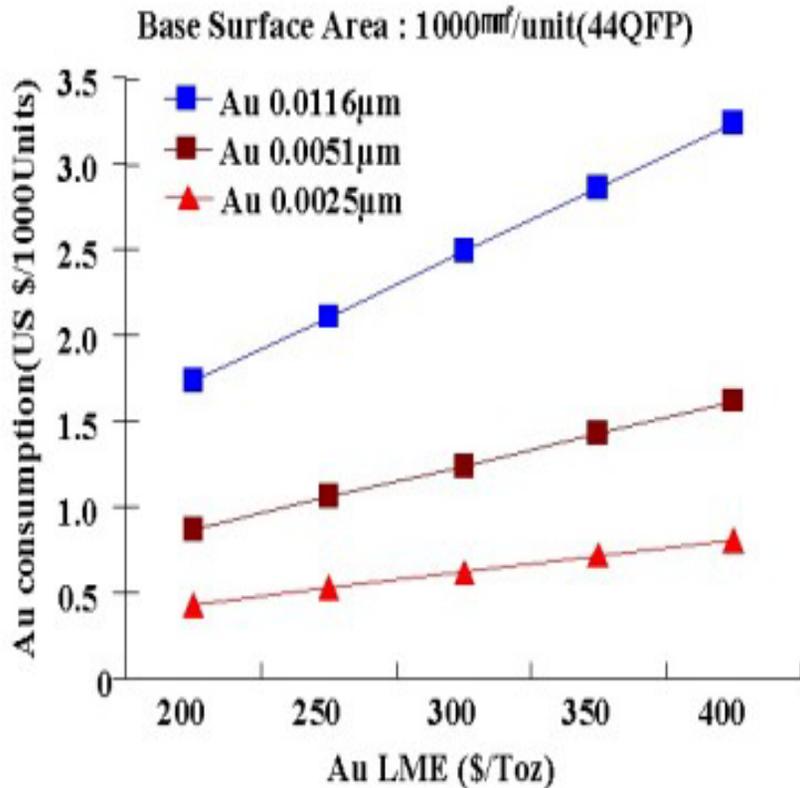
# Au Price History



27 October 2005

S02-4-16

# PM Price v. Thickness, Sensitivity



# NiPd Based PPF v. Ag Spot

- Cost:
  - NiPdAu finished leadframes may be at a slight premium to Ag spot plated leadframes, but:
    - Do the material content and make some yield and throughput assumptions.
  - NiPdAu leadframe cost must be netted against post mold plate cost that is eliminated
  - Subcon A/T's may not embrace PPF since it eliminates significant value added.

# IC assembly process Concerns

- Plating cracking after lead forming
- Wire bond capillary life reduction

Texas Instruments in adopting NiPd based finishes, recognized that any new IC lead finish would have to be a “drop in” replacement for the IC assembly/ test site and the end user.

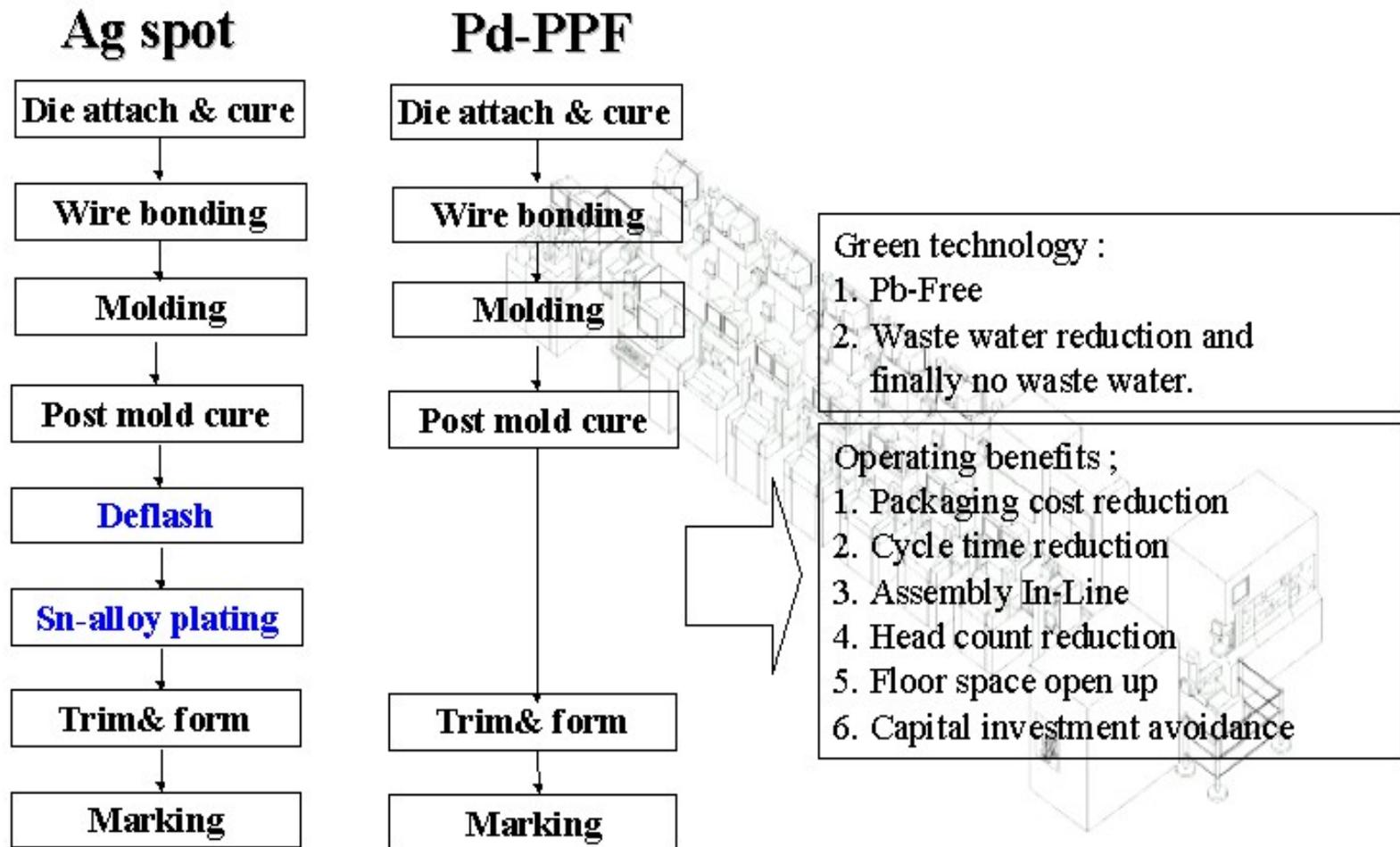
# End User Issues

## TI Experience:

The introduction of tens of billions of NiPd and NiPdAu finished IC's over a 15-year period has been remarkably transparent to the end users.

What concerns there have been are related to board level solderability. NiPd PPF solder joints “look different”.

# IC assembly comparison Sn-post plating vs. NiPdAu Pre-plating



# Implications of Previous Foil

Solderable finish applied by the leadframe maker.

- Plating control at the leadframe maker essential
  - Pd and Au are very difficult to measure at specified thicknesses.
  - Must be vigilant for handling/contamination.

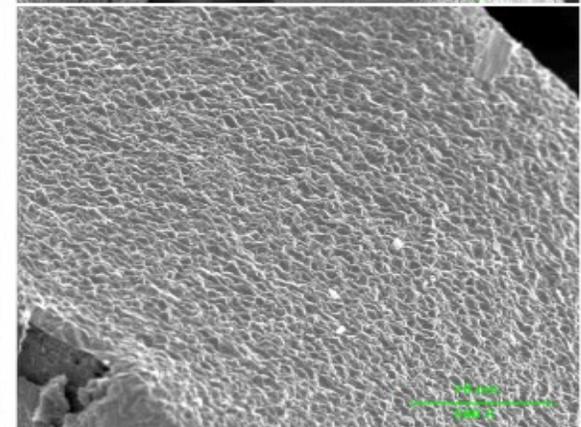
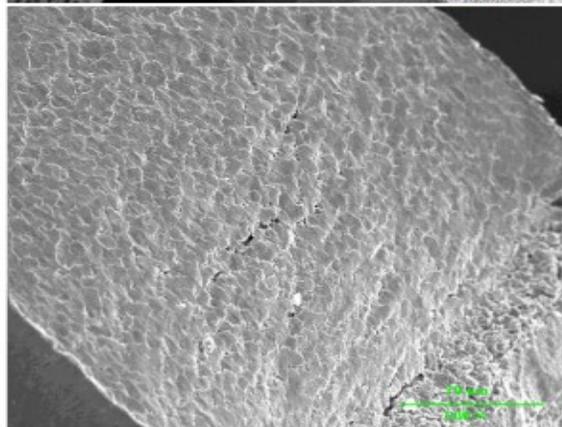
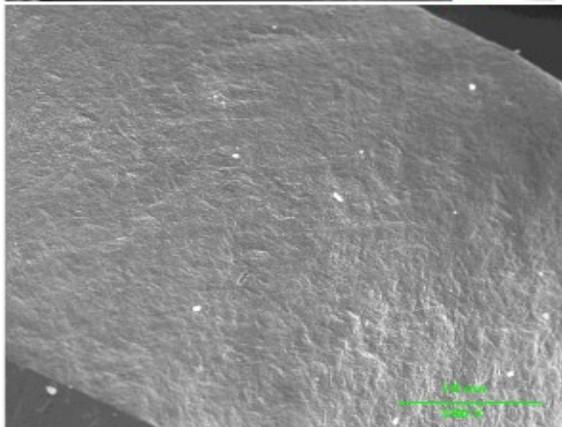
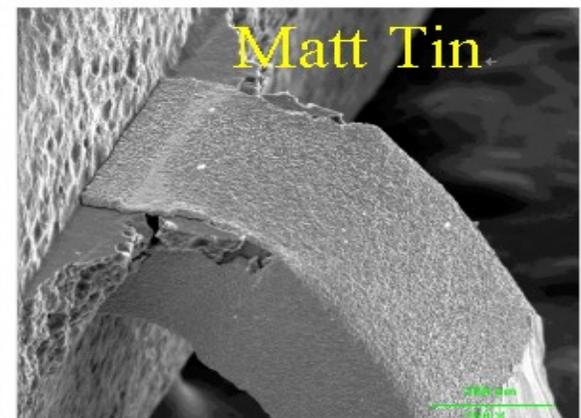
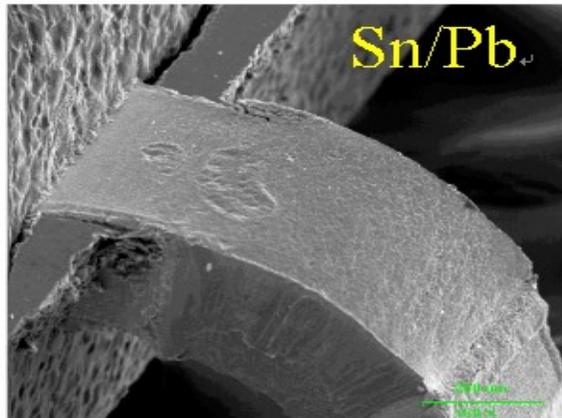
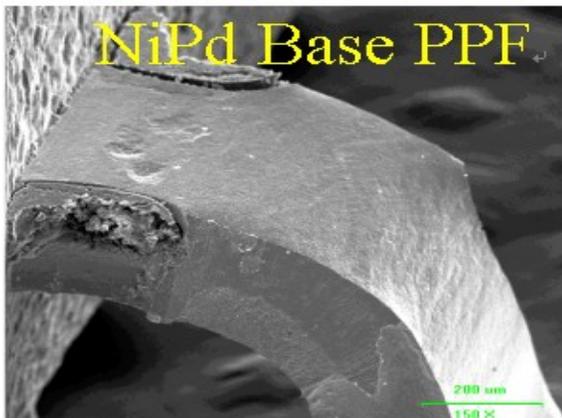
The good news:

- Fewer defect opportunities in leadframe plating
- Very long shelf life, >8 years
- Resistant to oxidation/tarnish
- Built in fail safe – no Pd = no wire bond.
- NiPdAu PPF eliminates post mold plating costs.

# Trim/Form Cracks

- Leadframe Cu alloys can **crack** (yield) during forming.
- Crack propagates through Ni barrier layer create micro-cracks at the surface.
- Pd and Au cracking are unobservable - these metals are so thin.
- Ductile Ni that “stretches” over the Cu cracks and forming tool optimization minimize cracks.
- Trim/Form tooling optimization is key = experience.
- **Bonus – because NiPdAu is relatively hard and thin, virtually no flaking, burring, slivers seen at T/F.**

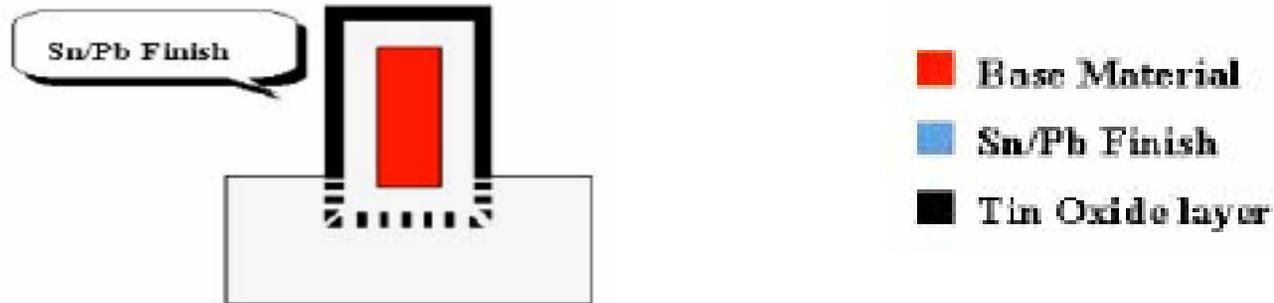
# Trim/Form Cracking Lead Shoulder (14-I SOP)



# Solderability

- In NiPdAu PPF's, the Pd and Au layers protect the Ni from oxidation.
- The Ni is the functional layer.
- Pd and Au are sacrificial coatings.
- Solderability speed depends on how fast Pd and Au dissolve into the molten solder.
- NiPdAu PPF's pass the JEDEC standard (J-STD-002B) for non-fusible coatings.

# Sn/Pb or Matte Sn Soldering

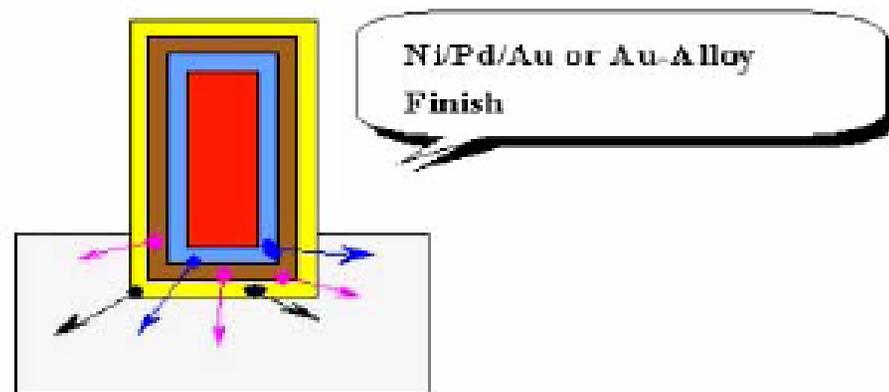


## Mechanical & Liquid state Diffusion

- ✓ Tin oxide layer is broken by expansion of molten under-layer at melting point
- ✓ Sn/Pb layer is exposed through cracking of oxide layer and makes an oxide free surface
- ✓ Take place a soldering (mechanically mixed oxide free Sn/Pb layer with molten solder and Tin oxide dissolves in molten solder )
- ✓ Solder joint is SnCu intermetallics.

# NiPd PPF Soldering Mechanism

- Base Material
- Nickel Layer
- Pd Layer
- Au/Au-alloy layer

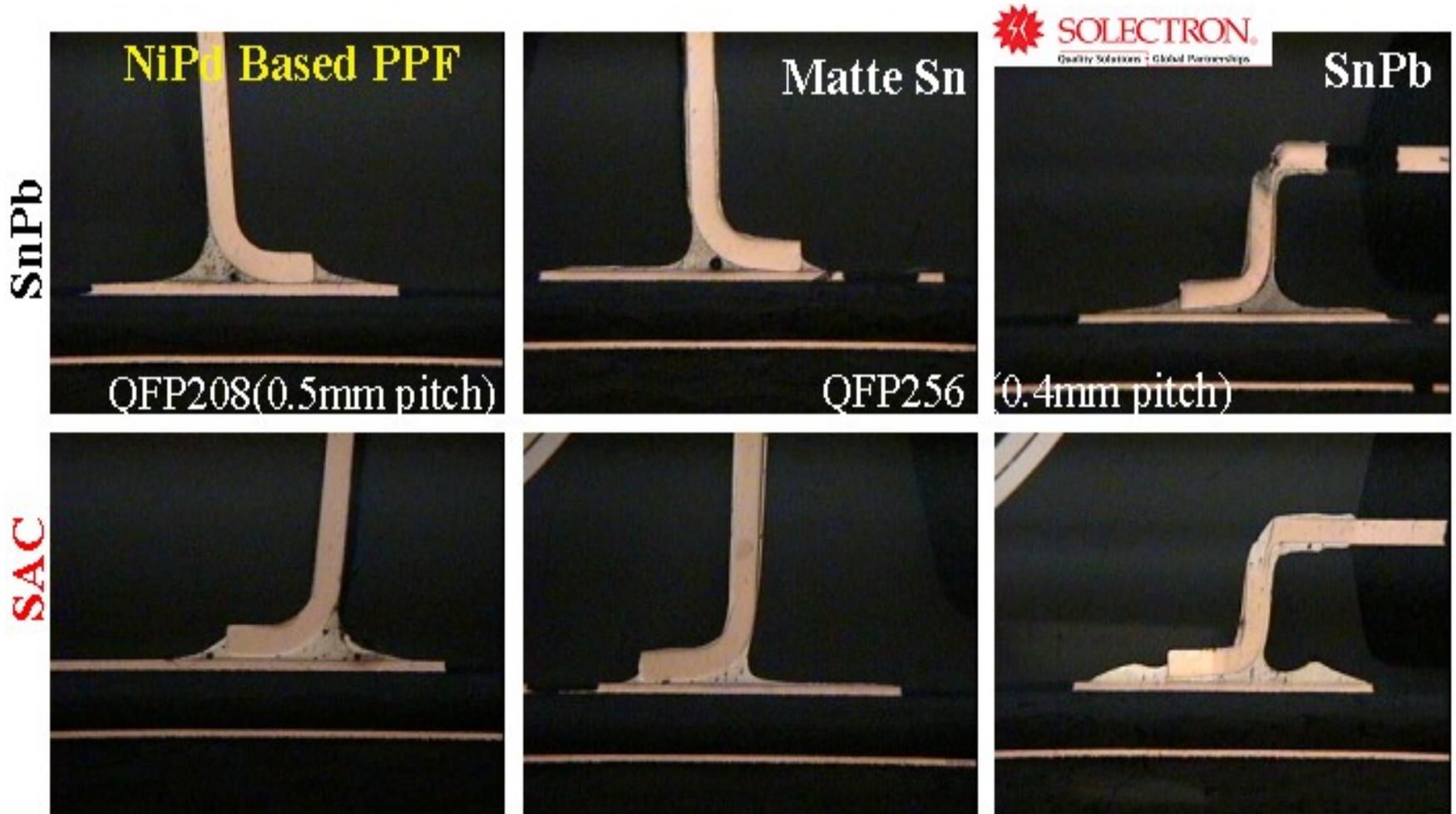


- ✓ Au and Pd dissolve in molten solder.
- ✓ Solder joint is SnNi inter-metallic. Pd and Au are dispersed in the bulk solder of the joint.
- ✓ It is a simple dissolution of Pd into the molten solder.
- ✓ The higher the temperature the faster the soldering.
- ✓ SAC solder with higher melting points make Pd based finishes wet quicker, i.e. dissolve faster
- ✓ The solder joint is made to the Ni. The Pd is a sacrificial layer.

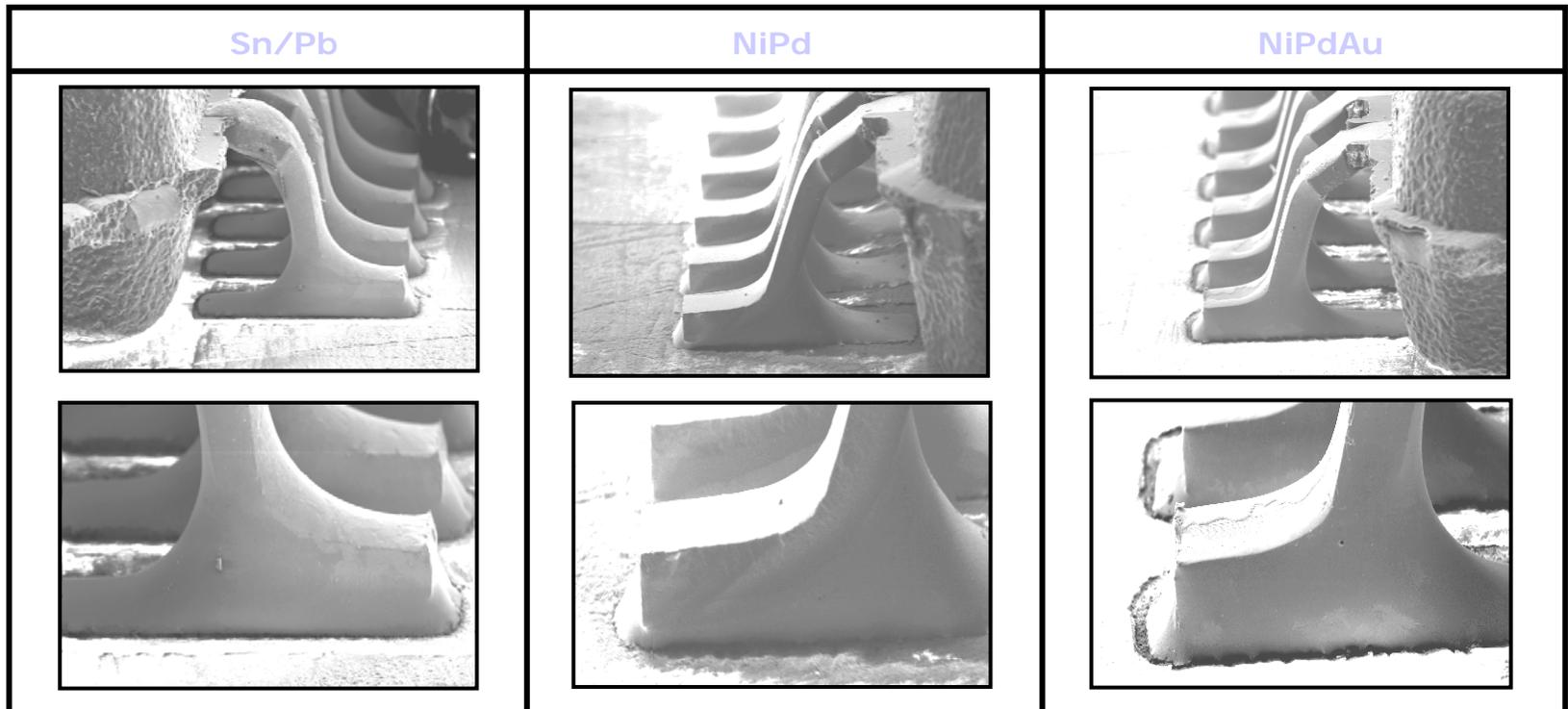
# Solderability

- Some end users do steam age preconditioning.
- Steam aging is an accelerated aging method developed for Sn based, fusible coatings.
- For non-fusible coatings, care must be taken to prevent surface contamination that can act as a solder mask and prevent solder wetting the PdAu.
- Since Pd and Au are noble metals, properly done steam aging will have no effect on solderability.

# Solder Fillet shape



# Solder Joint Comparison



# Recommendations for Further Work

- MSL performance of NiPdAu leadframe finishes (and for all leadframe finishes) is an area of concern.
- It is a complex problem requiring the collaboration of leadframe suppliers, die attach adhesive and mold compound manufacturers.
- MSL improvement with NiPdAu is “easier” because of NiPdAu’s remarkable consistency compared to Ag spot plated leadframes.

# Variability in Cu Surface

- Cu strike
- Anti-immersion treatments in Ag spot plating
- Ag immersion on Cu
- Anti-tarnish/anti-resin bleedout treatments for Cu
- Cu oxide thickness depends on Cu alloy, Ag plating, die attach and wire bond thermal history and chemical history.
  
- With NiPdAu – top surface is Au or Pd/Au.

# Conclusions

- NiPd based PPF's are economical and effective Pb-free finishes for IC leads (terminations).
- There is no risk of Sn whiskers with NiPd PPF.
- There are tens of billions IC's in use with NiPd based PPF finished leads that have been sold over the past 15 years.
- The key issue, cost of the NiPdAu finished leadframes has been addressed by reducing the Pd content by ~7X and adding an ultra thin (30~100 angstrom) top layer of Au.

# Acknowledgements

This **High Density Packaging User Group** that sponsored the "*Technical Description of Nickel-Palladium based Component Terminal Finishes*" project report.

## Contributing Organizations

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